## Notice of References Cited Application/Control No. 10/620,596 Examiner Tai Duong Applicant(s)/Patent Under Reexamination NAM, SEUNG HEE Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*	•	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,798,442	09-2004	Kim et al.	348/43
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-		·	
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
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	Ъ					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	<b>V</b>	
	<b>&gt;</b>	
	х	

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